

66100

MICROCOUPLER, STANDARD TRANSISTOR OUTPUT



**OPTOELECTRONIC PRODUCTS
DIVISION**

08/24/2011

Features:

- Radiation tolerant version available
- Small size saves real estate
- Large thick film gold bond pads
- Element evaluation on request
- Electrically similar to 4N2X and 4N4X couplers

Applications:

- Eliminate ground loops
- Level shifting
- Line receiver
- Solid state switching
- Switching power supplies

DESCRIPTION

The **66100** microcoupler is a single channel optocoupler consisting of an LED optically coupled to a light sensitive silicon phototransistor. Each microcoupler is provided with full 100% DC testing with sample element evaluation available. All microcouplers are capable of operating over the full military temperature range (-55°C to +125°C).

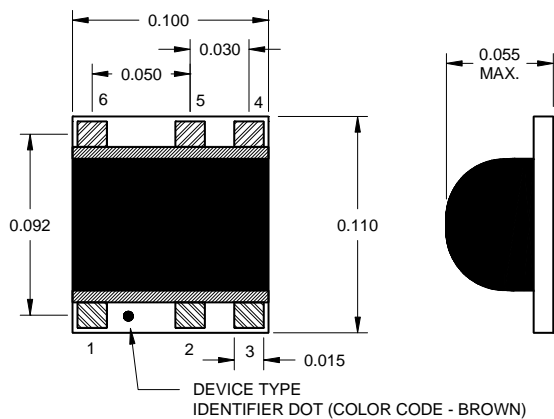
ABSOLUTE MAXIMUM RATINGS

Input to Output Isolation Voltage	1 kV
Input Diode Continuous Forward Current	40 mA
Peak Forward Input Current (value applies for $t_w \leq 10\mu s$, $PRR < 300$ pps).....	1 A
Reverse Input Voltage	6 V
Input Power Dissipation (Note 1)	80 mW
Emitter-Base Voltage.....	7 V
Collector-Emitter Voltage (Value applies to emitter-base open-circuited and the input diode equal to zero).....	60 V
Collector-Base Voltage	60 V
Continuous Collector Current	50 mA
Continuous Transistor Power Dissipation (Note 2)	300 mW
Storage Temperature.....	-65°C to +150°C
Operating Free-Air Temperature Range	-55°C to +125°C

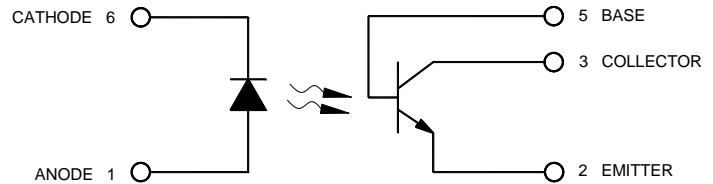
Notes:

1. Derate linearly at the rate of 1.33 mW/°C above 65°C.
2. Derate linearly at the rate of 3 mW/°C above 25 °C.

Package Dimensions



Schematic Diagram



ELECTRICAL CHARACTERISTICST_A = 25°C unless otherwise specified.

PARAMETER	SYMBOL	MIN	TYP	MAX	UNITS	TEST CONDITIONS	NOTE
Input Diode Static Reverse Current	I _R			10	μA	V _R = 2 V	
Input Diode Static Forward Voltage -55°C	V _F	1.0		2.0	V	I _F = 10 mA	
Input Diode Static Forward Voltage +25°C	V _F	0.8	1.4	1.5	V	I _F = 10 mA	
Input Diode Static Forward Voltage +100°C	V _F	0.8		2.0	V	I _F = 10 mA	

OUTPUT TRANSISTORT_A = 25°C unless otherwise specified.

PARAMETER	SYMBOL	MIN	TYP	MAX	UNITS	TEST CONDITIONS	NOTE
Collector-Base Breakdown Voltage	V _{(BR)CBO}	45			V	I _C = 100 μA, I _B = 0, I _F = 0	
Collector-Emitter Breakdown Voltage	V _{(BR)CEO}	40			V	I _C = 1 mA, I _B = 0, I _F = 0	
Emitter-Base Breakdown Voltage	V _{(BR)EBO}	7			V	I _C = 0 mA, I _E = 100 μA, I _F = 0	
Off-State Collector Current +100°C	I _{CEO}			100 100	nA μA	V _{CE} = 20 V, I _F = 0 mA, I _B = 0	

COUPLED CHARACTERISTICST_A = 25°C unless otherwise specified.

PARAMETER	SYMBOL	MIN	TYP	MAX	UNITS	TEST CONDITIONS	NOTE
On State Collector Current	I _{C(ON)}	2.0			mA	V _{CE} = 5 V, I _F = 1 mA, I _B = 0	
On State Collector Current +100°C	I _{C(ON)}	2.0			mA	V _{CE} = 5 V, I _F = 2 mA, I _B = 0	
On State Collector Current -55°C	I _{C(ON)}	2.8			mA	V _{CE} = 5 V, I _F = 2 mA, I _B = 0	
Collector-Emitter Saturation Voltage	V _{CE(SAT)}			0.3	V	I _F = 2 mA, I _C = 2 mA	
Input to Output Isolation Voltage	V _{I-O}	1000			V	I _{I-O} = 100 nA	1
Rise Time-Phototransistor Operation	t _r		10	25	μs	V _{CC} = 10 V, I _F = 10 mA, R _L = 100 Ω, I _B = 0	2
Fall Time-Phototransistor Operation	t _f		10	25	μs	V _{CC} = 10 V, I _F = 10 mA, R _L = 100 Ω, I _B = 0	2

NOTES:

- These parameters are measured between all phototransistor leads shorted together and with both input diode leads shorted together.
- This parameter must be measured using pulse techniques (t_W = 100 μs duty cycle ≤ 1%).

RECOMMENDED OPERATING CONDITIONS:

PARAMETER	SYMBOL	MIN	MAX	UNITS
Input Current, Low Level	I _{FL}	0	90	μA
Input Current, High Level	I _{FH}	2	10	mA
Supply Voltage	V _{CE}	5	10	V
Operating Temperature	T _A	-55	125	°C

SELECTION GUIDE

PART NUMBER	PART DESCRIPTION
66100-001	Commercial
66100-101	Commercial with element evaluation
66100-002	Radiation tolerant
66100-102	Radiation tolerant with element evaluation